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(12) **United States Design Patent** (10) **Patent No.:** **US D915,963 S**
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(54) **INSTRUMENT CLUSTER WITH DISPLAYED IMAGE DESIGN**

(71) Applicant: **Hyundai Mobis Co., Ltd.**, Seoul (KR)

(72) Inventors: **Bo Young Park**, Seongnam-si (KR);
Hyung Soo Kim, Seongnam-si (KR);
Min Hee Kim, Yongin-si (KR); **Jin Yung Bae**, Yongin-si (KR)

(73) Assignee: **Hyundai Mobis Co., Ltd.**, Seoul (KR)

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(52) **U.S. Cl.**
USPC **D12/192**

(58) **Field of Classification Search**
USPC D12/192, 415, 114, 345; D15/17, 28;
D10/46, 98, 102-103, 122-12; D23/324
CPC B60H 1/34; B60H 1/3407; B60H 1/3414;
B60H 1/3421; B60H 1/3428; B60H
1/3435; B60H 1/3442; B60H 1/345;
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See application file for complete search history.

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Primary Examiner — Katrina A Betton

(74) *Attorney, Agent, or Firm* — H.C. Park & Associates, PLC

(57) **CLAIM**

The ornamental design for an instrument cluster with displayed image design, as shown and described.

DESCRIPTION

FIG. 1 is a front view of an instrument cluster with displayed image design showing our new design; and, FIG. 2 is an enlarged view of FIG. 1.

The broken lines shown in FIG. 1 illustrate portions of the instrument cluster that form no part of the claimed design.

1 Claim, 2 Drawing Sheets

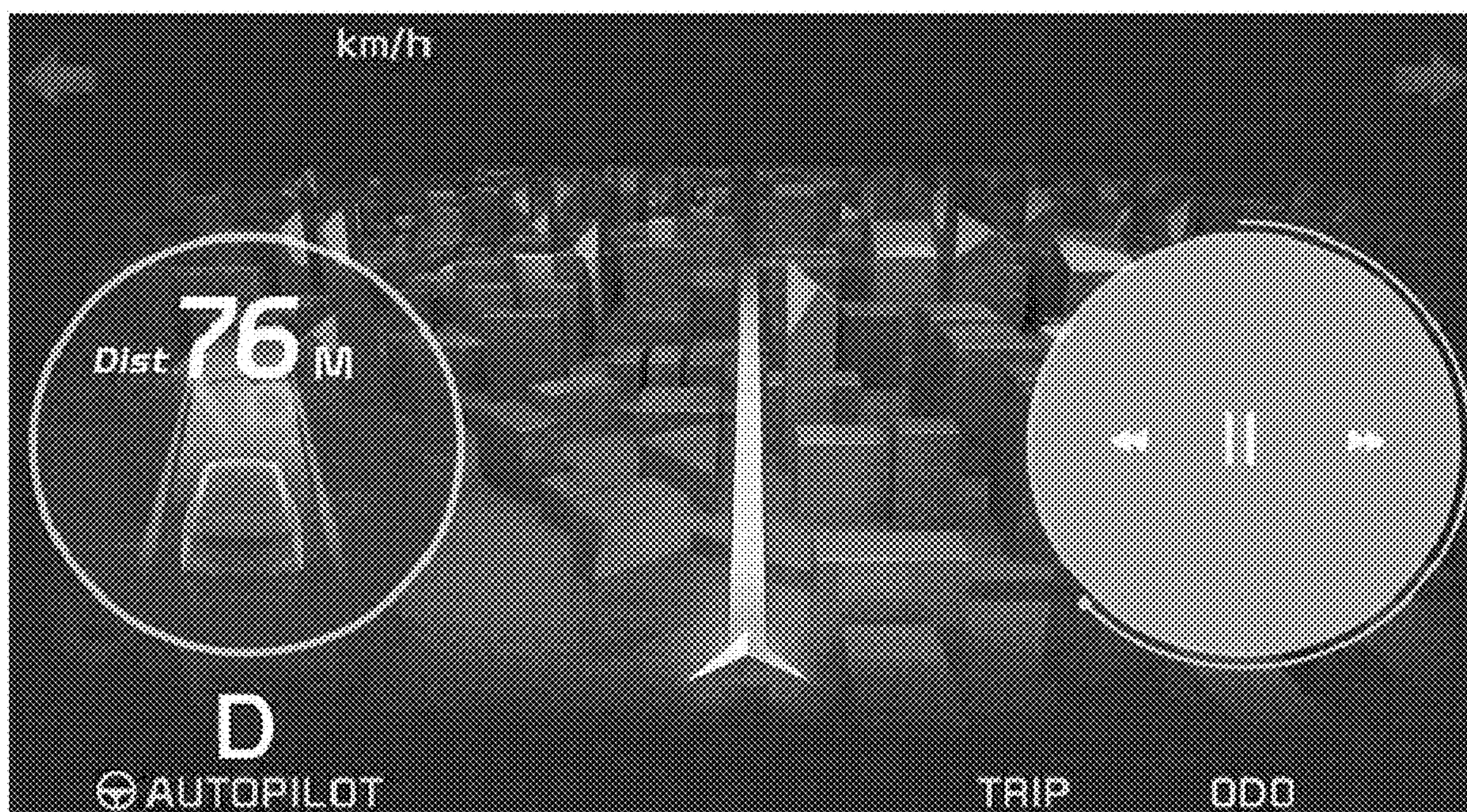


FIG. 1

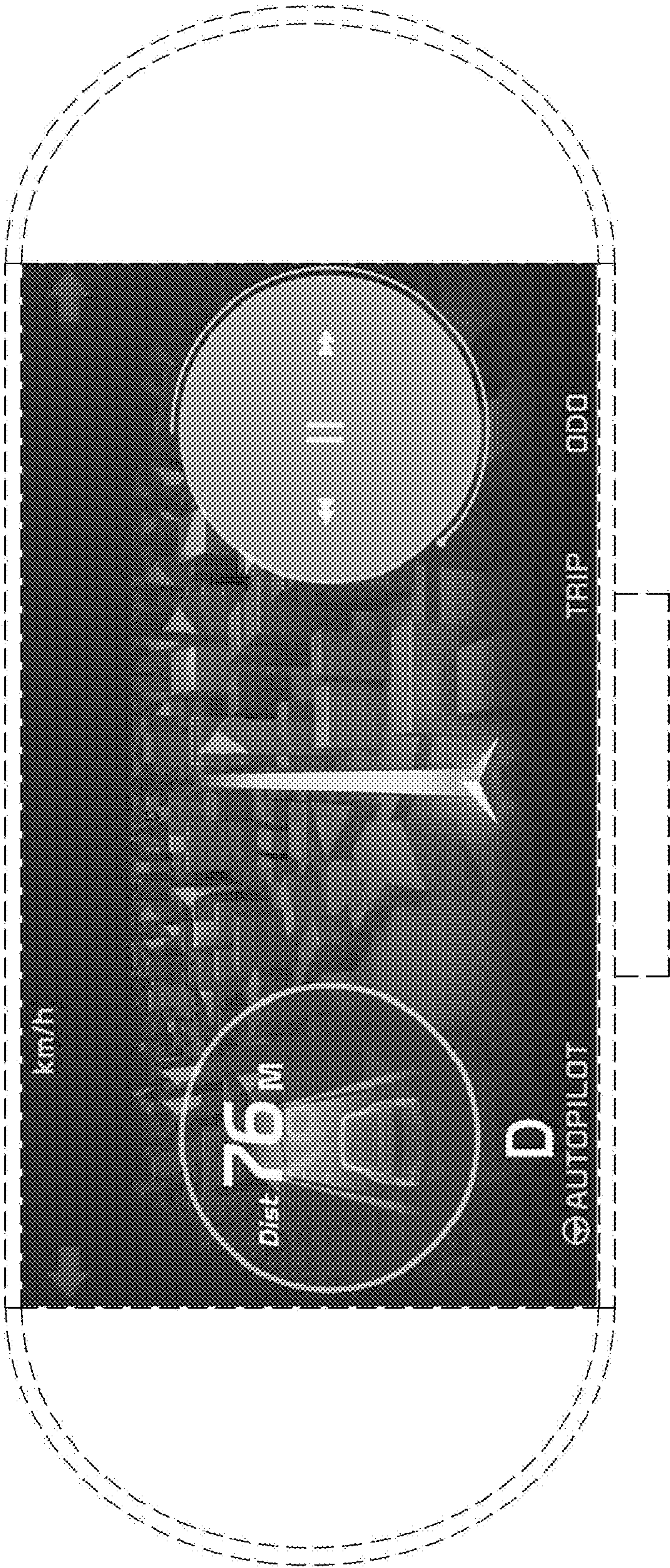


FIG. 2

